Search Notes	(continue	d)
--------------	-----------	----



Application/Control No.	Applicant(s)/Patent under Reexamination
10/775,419	TIWARI ET AL.
Examiner	Art Unit
Andro Diorro Lauio	2422

	SEAR	CHED	
Class	Subclass	Date	Examiner
703	2,11	10/27/2006	APL
716	004	10/27/2006	APL
	,		
			•
		4	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	
			
	 · 		
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (EAST (US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT;IBM_TDB)- SEE ATTACHMENT	10/27/2006	APL
Inventor Name Search	10/27/2006	APL
· · · · · · · · · · · · · · · · · · ·	·	
	· ·	